

# NILM Beyond Event Detection

J. Zico Kolter  
MIT CSAIL

NILM Workshop - 5/7/12

In collaboration with: Tommi Jaakkola

# Origins

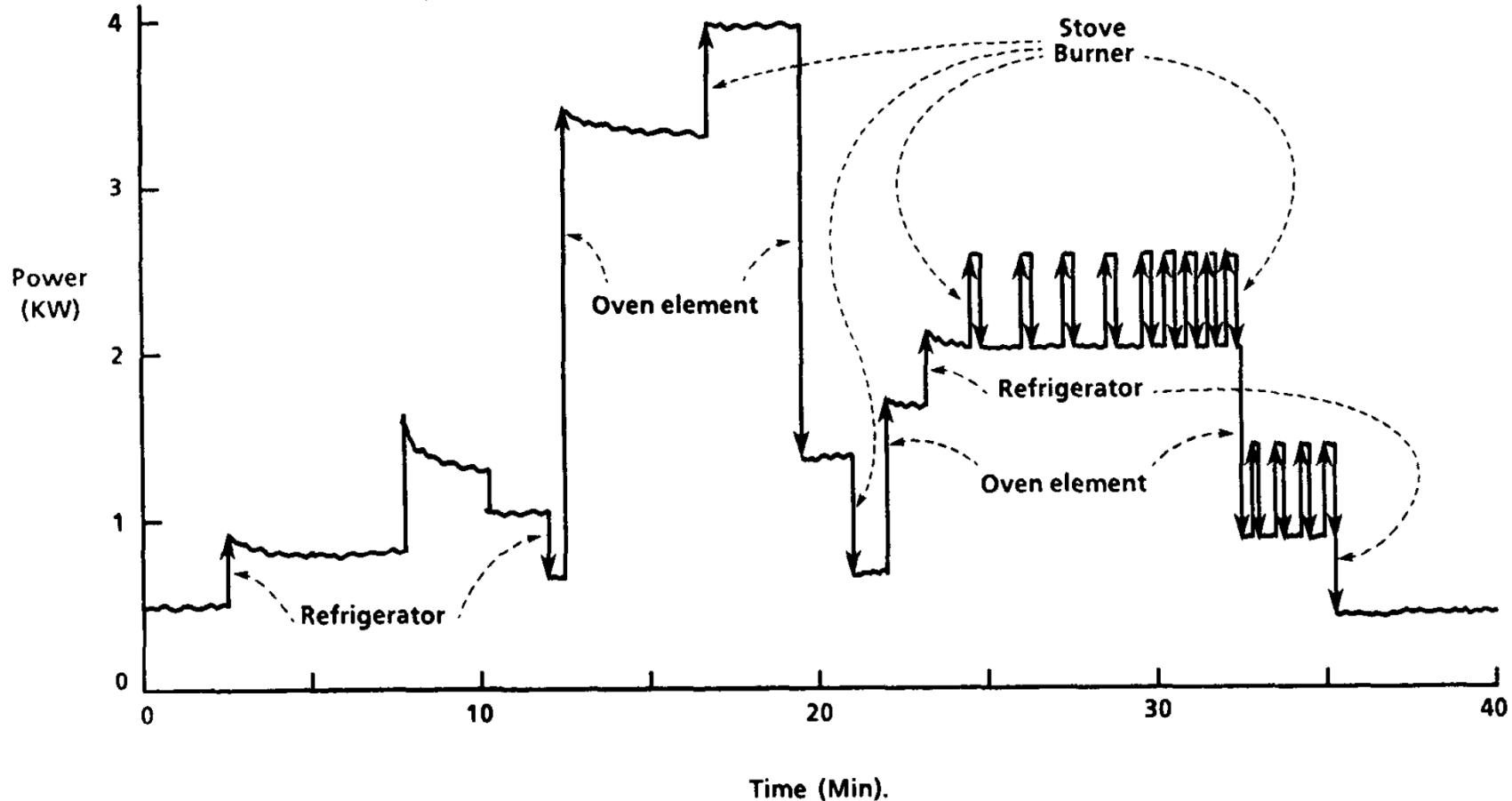


Figure from G.W. Hart, "Nonintrusive Application Load Monitoring."  
Proceedings of the IEEE, Vol 80 (12), 1992.

# Origins

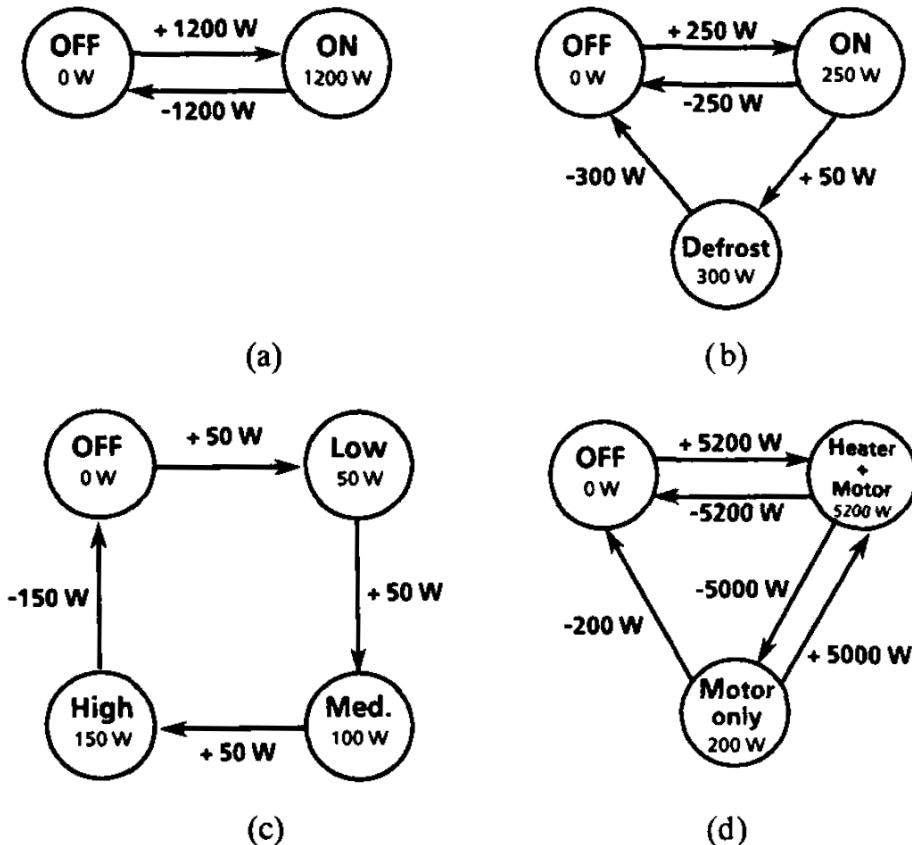


Fig. 4. Finite-state appliance models: (a) generic 1200 W two-state appliance, e.g., toaster; (b) refrigerator with defrost state; (c) "three-Way" lamp; (d) clothes dryer.

Figure from G.W. Hart,  
“Nonintrusive Application Load  
Monitoring.” Proceedings of the  
IEEE, Vol 80 (12), 1992.

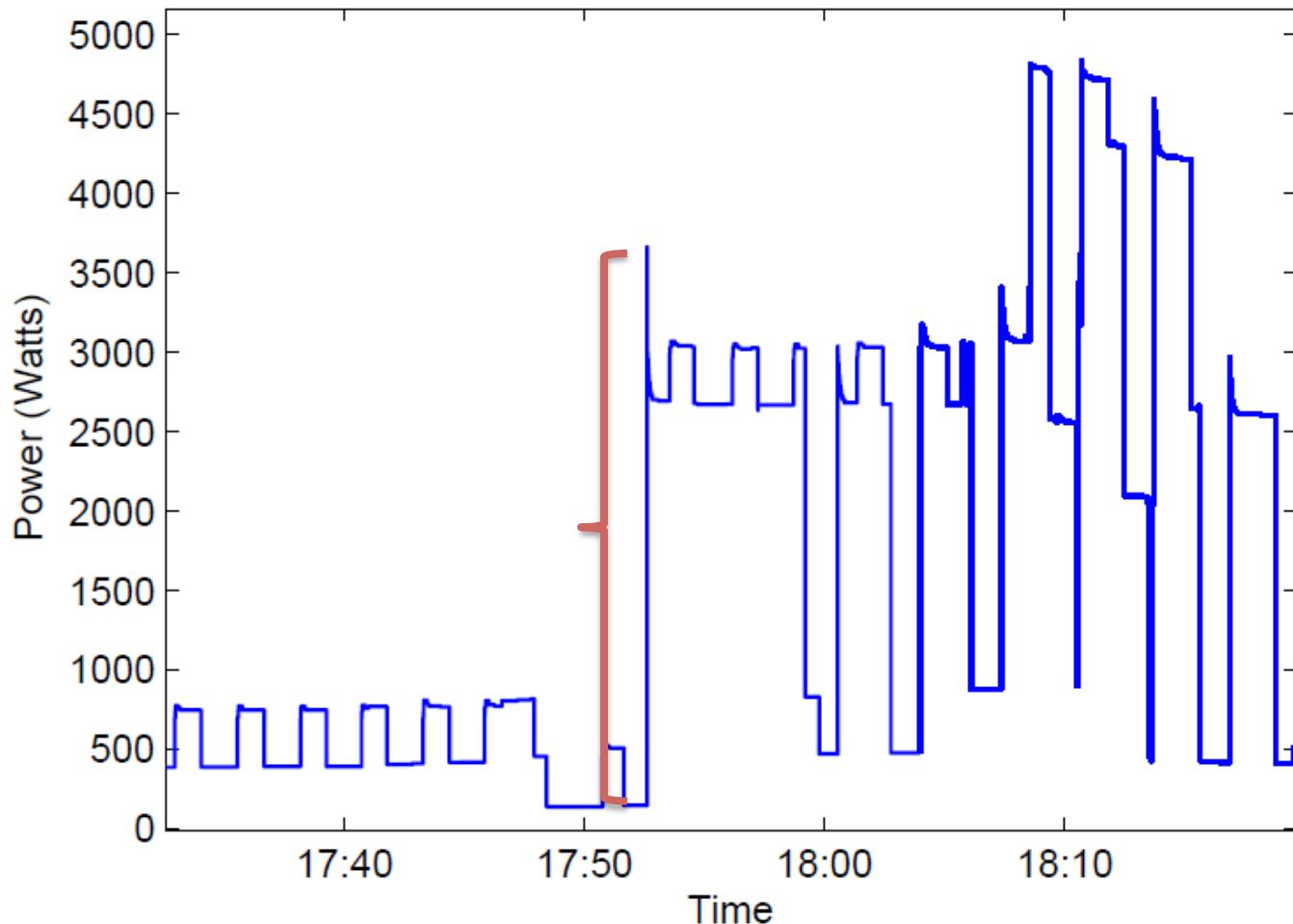
A. Bouloutas, G.W. Hart, M. Schwartz.  
“Two extensions of the Viterbi  
Algorithm.” IEEE Transactions on  
Information Theory, Vol 37 (3), 1991

G.W. Hart, A. Bouloutas. “Correcting  
Dependent Errors in Sequences  
Generated by Finite-State  
Processes.” IEEE Transactions on  
Information Theory, Vol 39 (4), 1991

# Typical Approach

## 1. *Specify* model

- For each device:  
 $\Delta P^{(i)}$



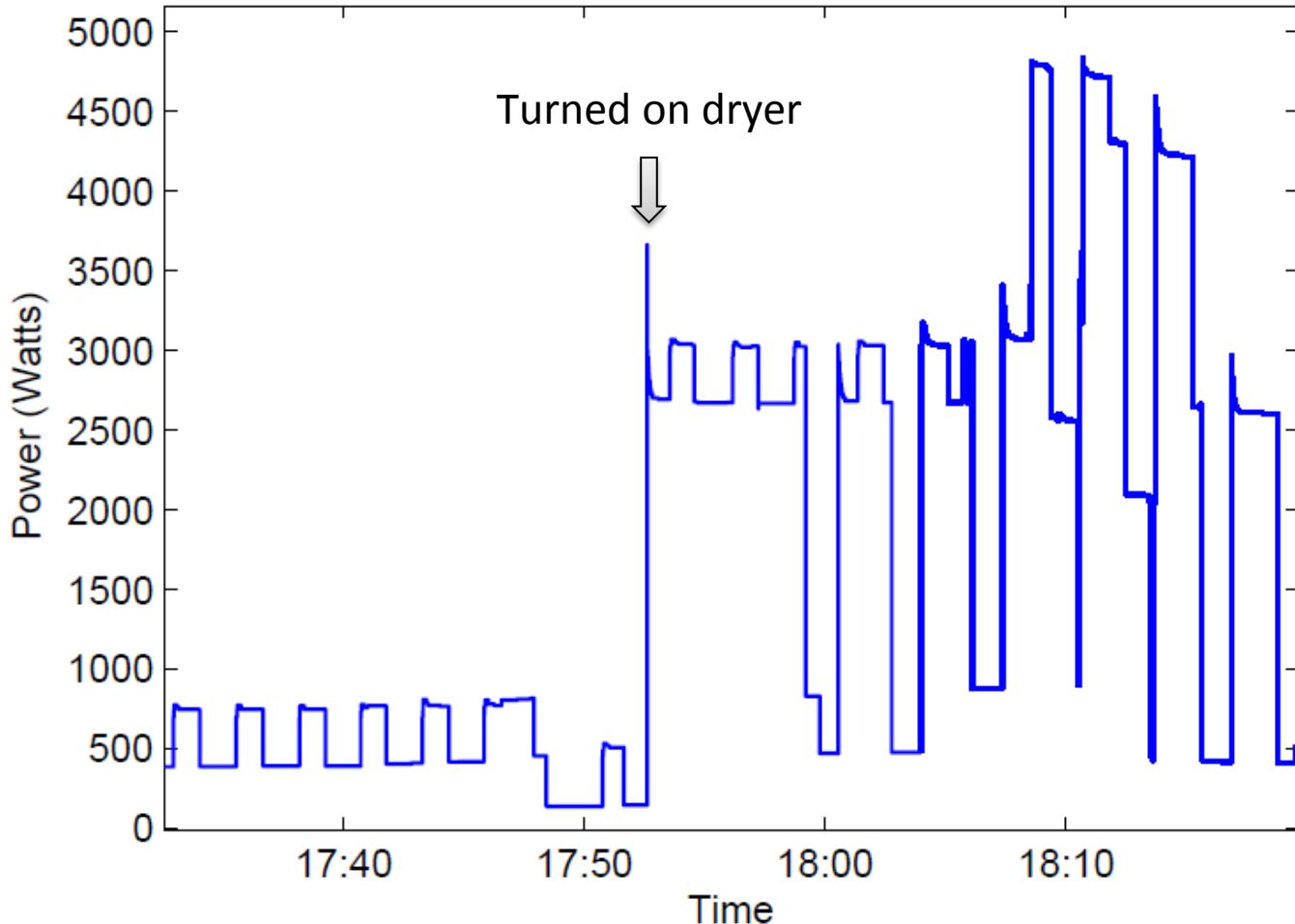
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## 2. *Learning* (supervised)

- Turn each device on/off, record power delta



# Typical Approach

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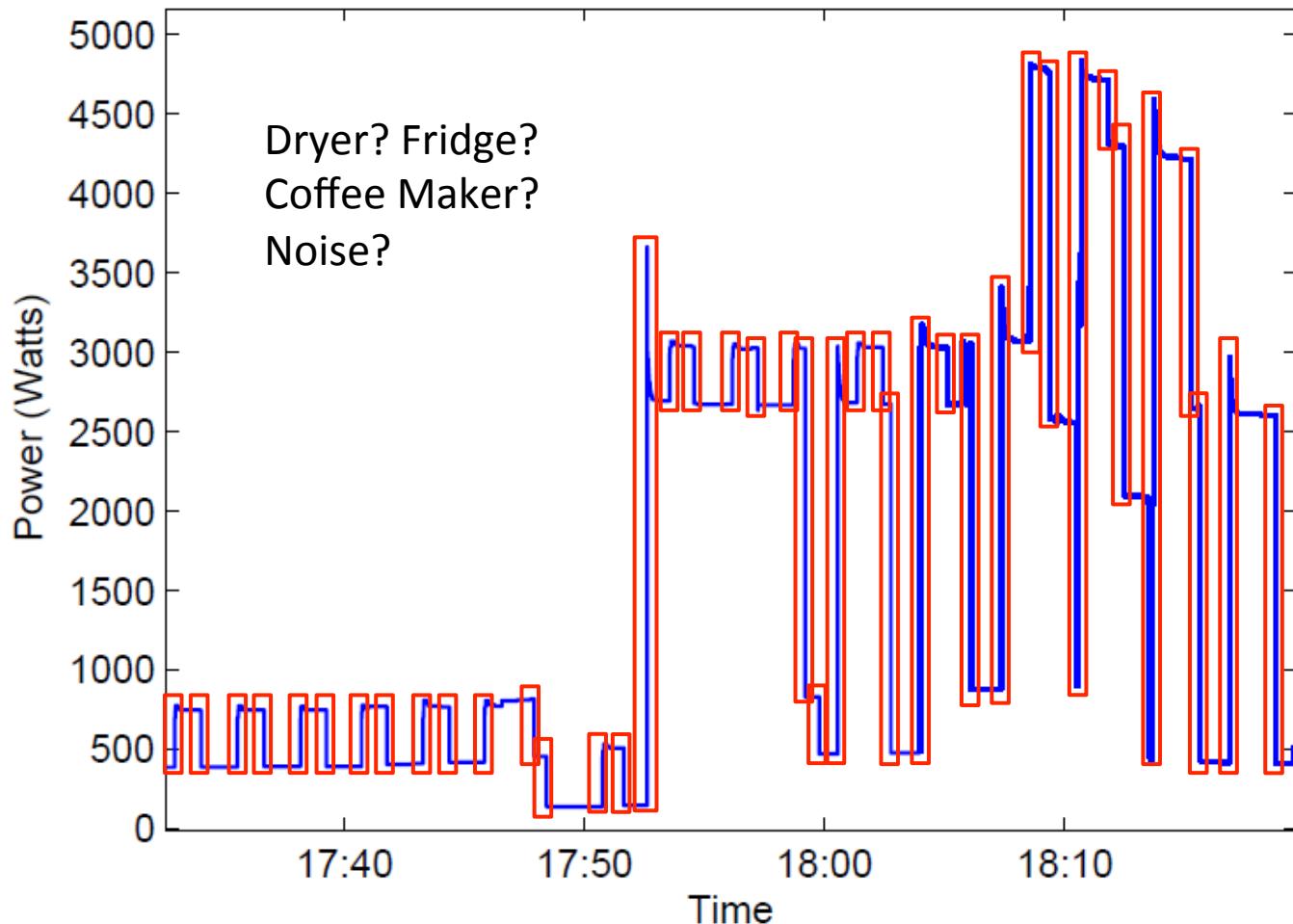
- For each device:  
 $\Delta P^{(i)}$

## 2. *Learning* (supervised)

- Turn each device on/off, record power delta

## 3. *Inference*

- For each change in power, find nearest device match



# Typical Approach

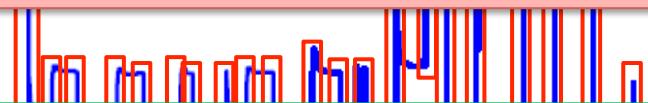
1. S

• F

**Fundamental Problem: Looking at energy  
“events” only in isolation**

2. *Learning*  
(supervised)

/atts) 3000



• T  
on/  
pow

**My Work: A “global” view of home energy**

1. More complex models that look at the entire power signal *jointly*

2. Learn devices models in *unsupervised* fashion

**Key challenge: More complex learning/inference**

# Problem Formulation

Find:

power consumptions  
for each device

$$y_1^{(1)}$$

$$y_2^{(1)}$$

$$y_3^{(1)}$$

...

$$y_T^{(1)}$$

$$y_1^{(2)}$$

$$y_2^{(2)}$$

$$y_3^{(2)}$$

...

$$y_T^{(2)}$$

+

$$\bar{y}_1$$

$$\bar{y}_2$$

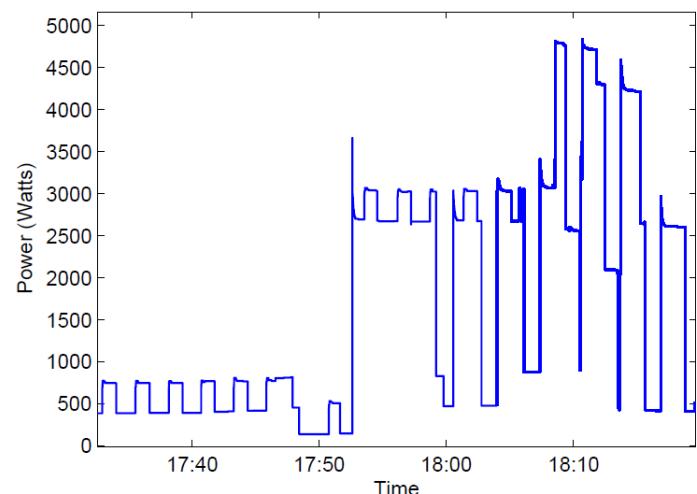
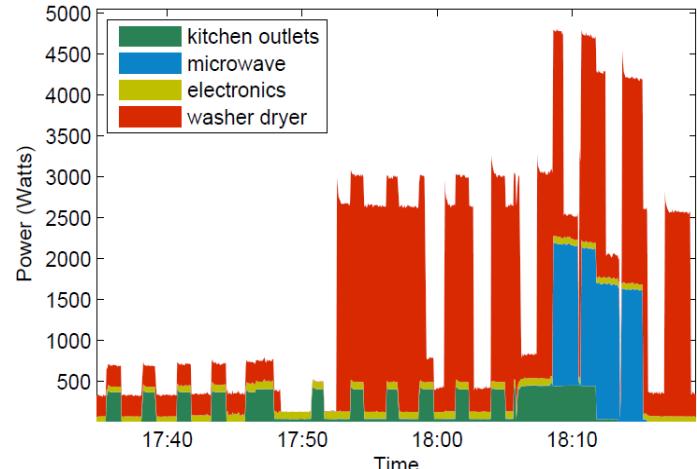
$$\bar{y}_3$$

...

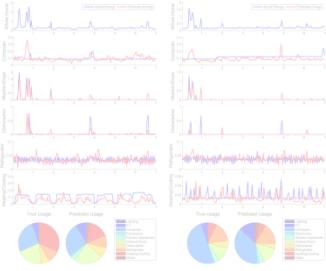
$$\bar{y}_T$$

Given:

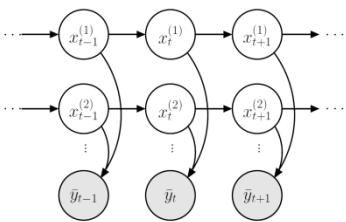
whole-home power  
consumption over time



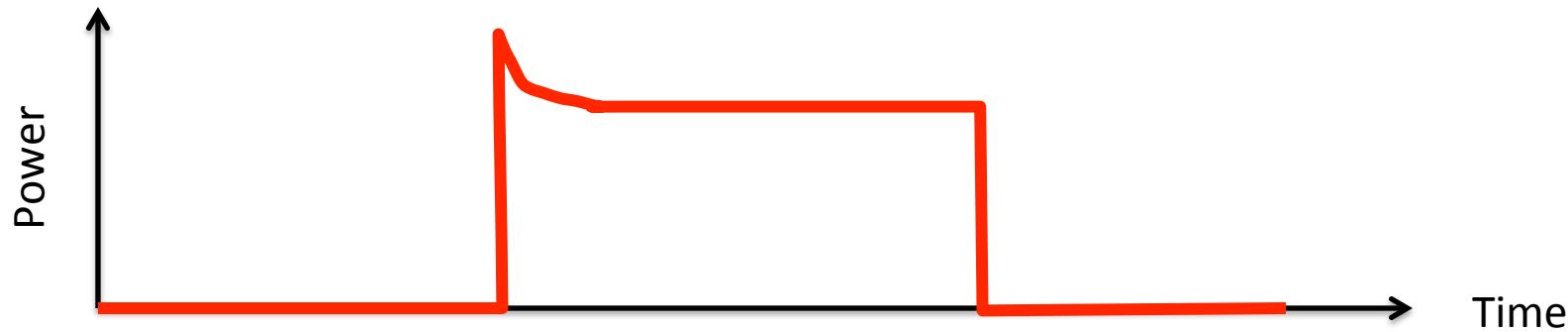
# Work on Disaggregation



- Initial work using discriminative sparse coding, hourly power data  
[Kolter, Batra and Ng, NIPS 2010]
- Data collection, compression, and a public dataset  
[Kolter and Johnson, KDDSUST 2011]
- Factorial HMM modeling and efficient approximate inference  
[Kolter and Jaakkola, AISTATS 2012]

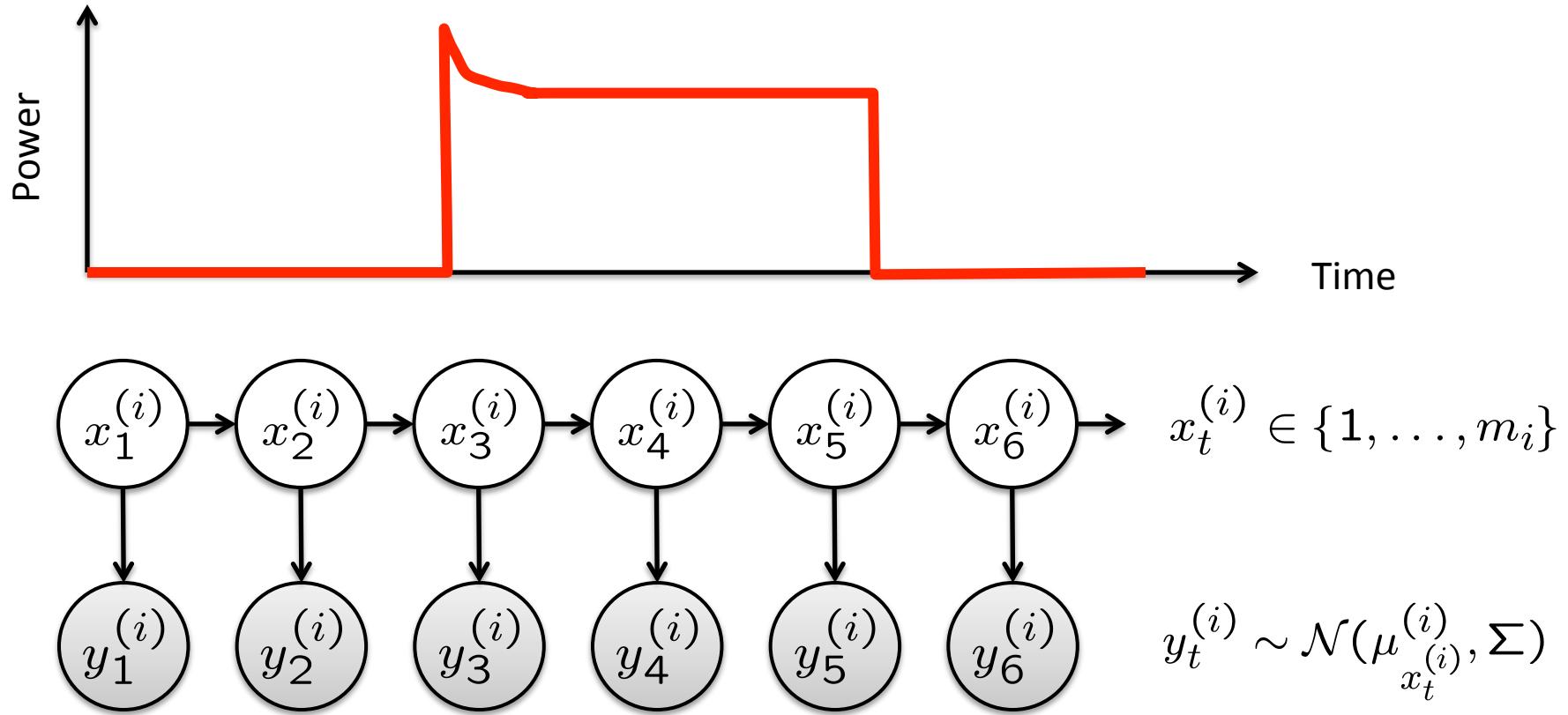


# Devices as Hidden Markov Models



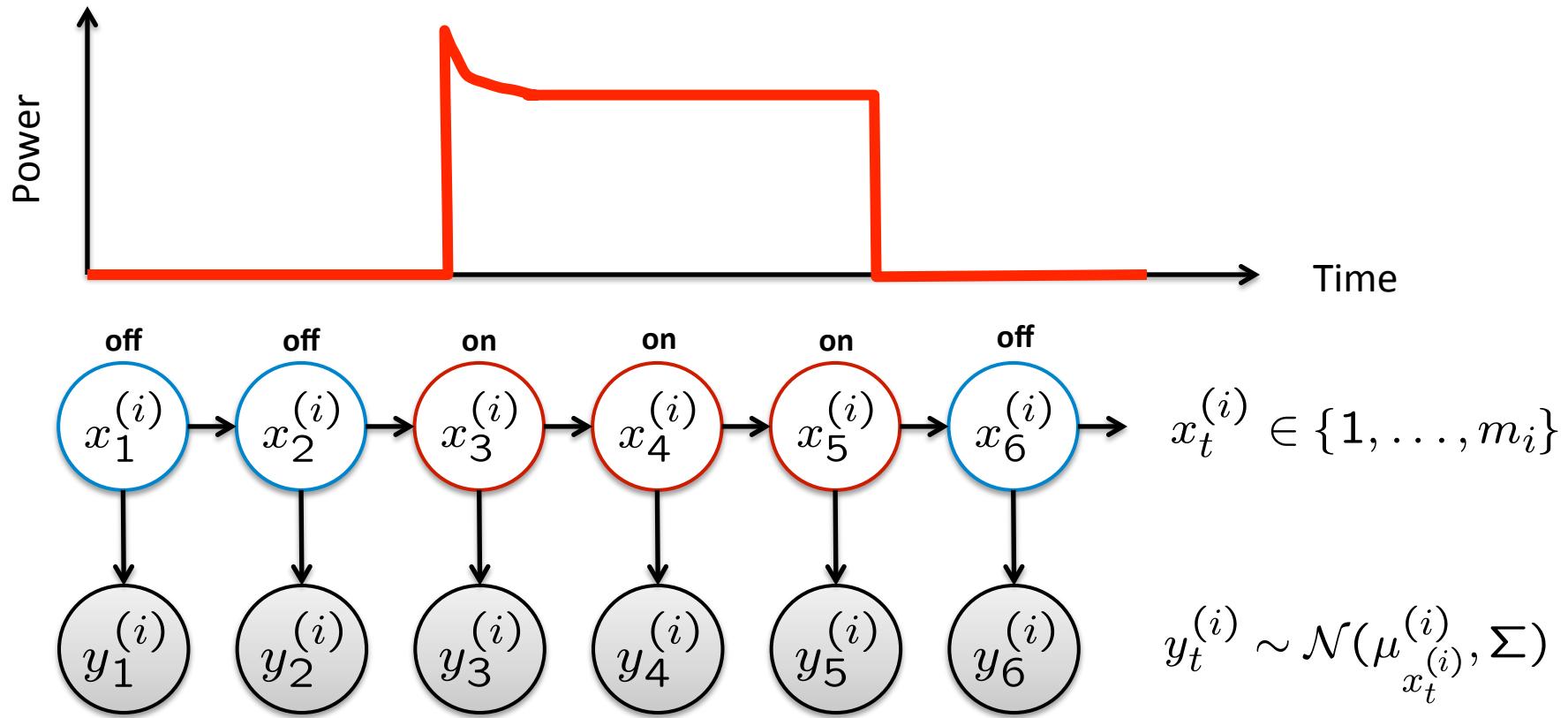
1. *Specify* model

# Devices as Hidden Markov Models



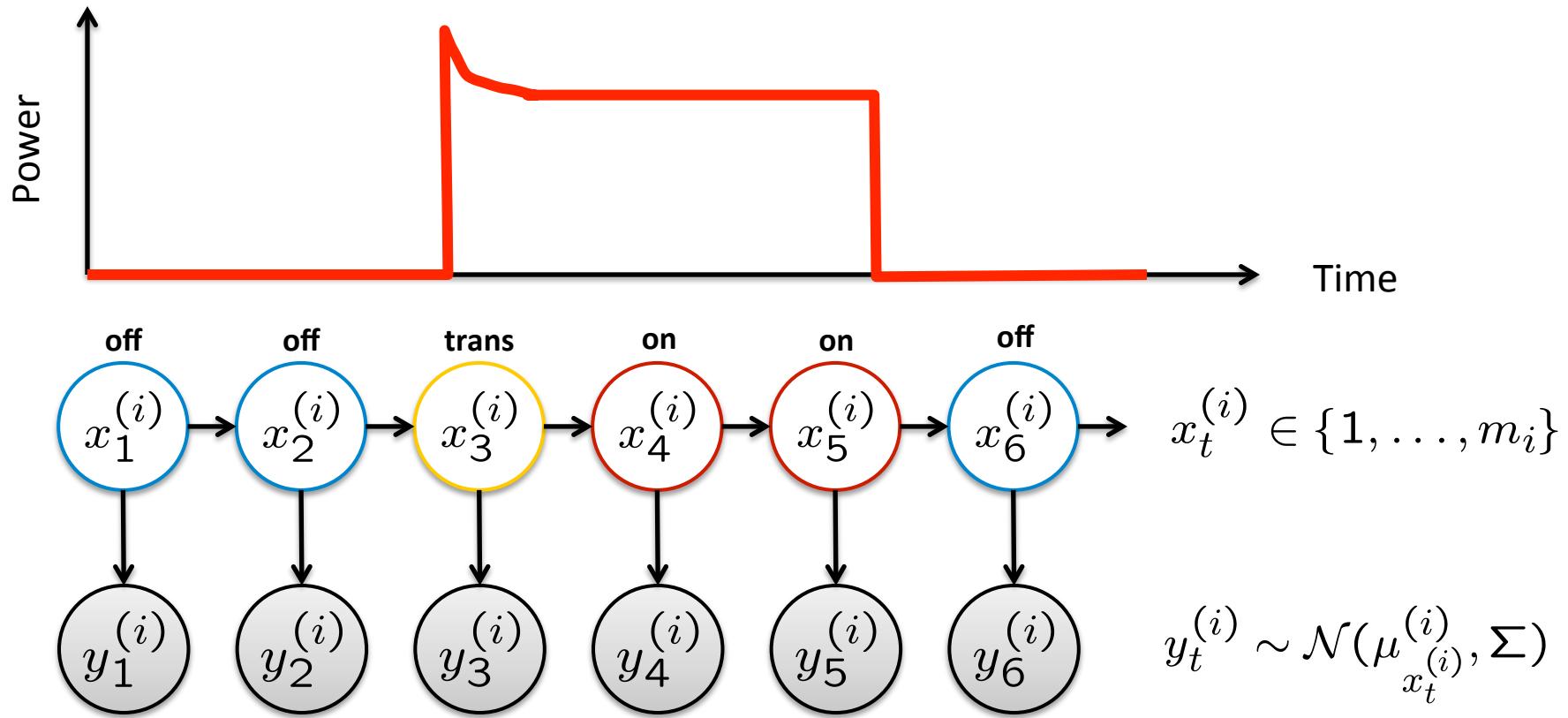
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# Devices as Hidden Markov Models



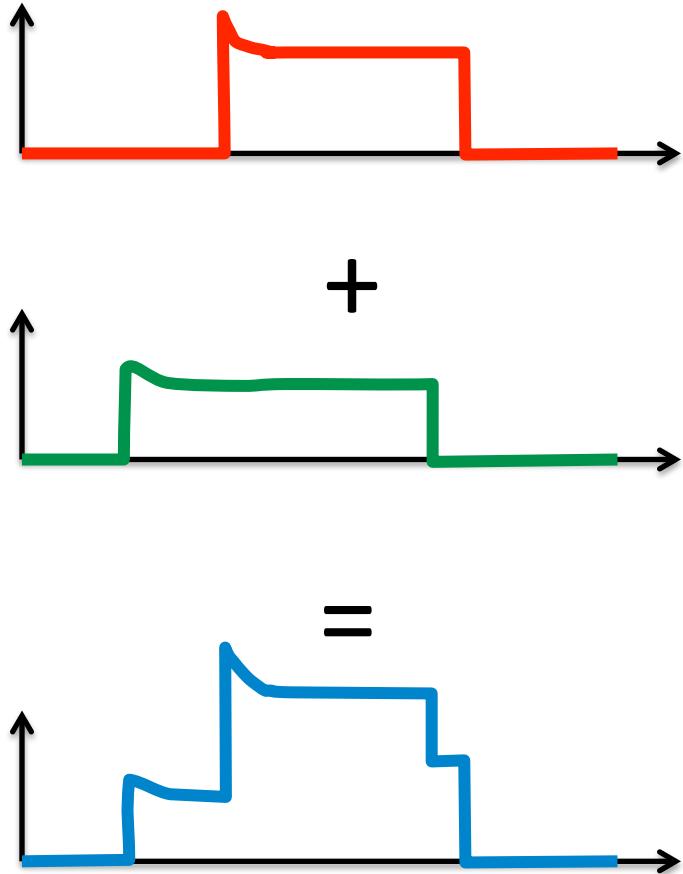
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# Devices as Hidden Markov Models

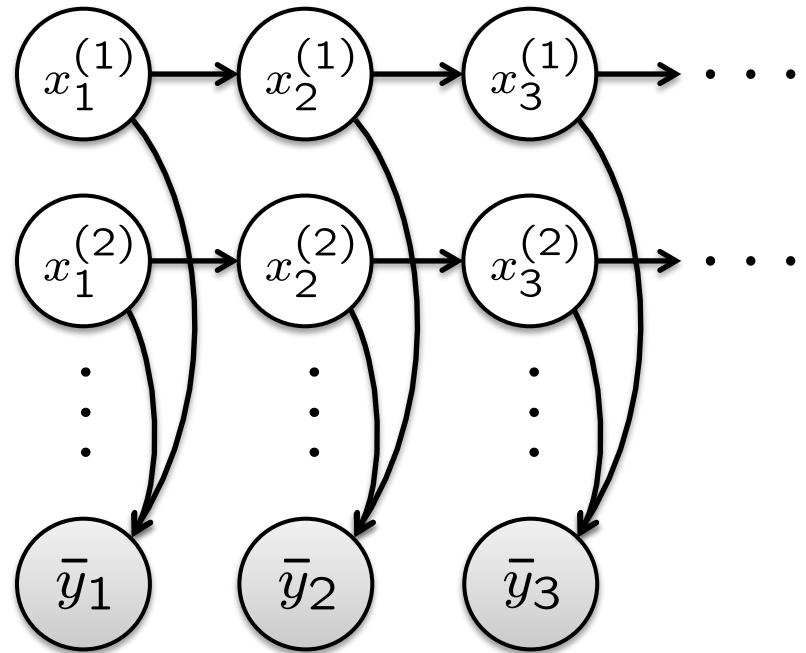


1. *Specify* model

# Factorial HMMs



1. *Specify* model

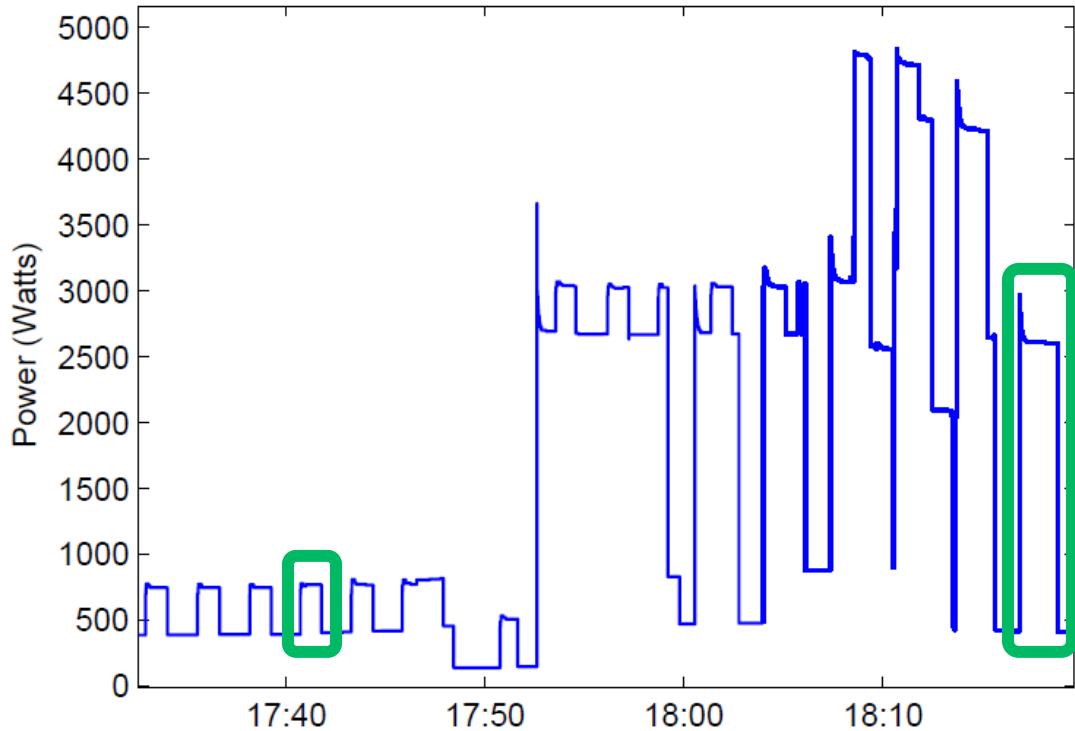


$$\bar{y}_t | x_t^{(1:N)} \sim \mathcal{N} \left( \sum_{i=1}^N \mu_{x_t^{(i)}}^{(i)}, \Sigma \right)$$

[Ghahramani and Jordan, 1997]

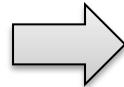
# Learning Device Models

**Intuition:** we do sometimes observe devices events in isolation



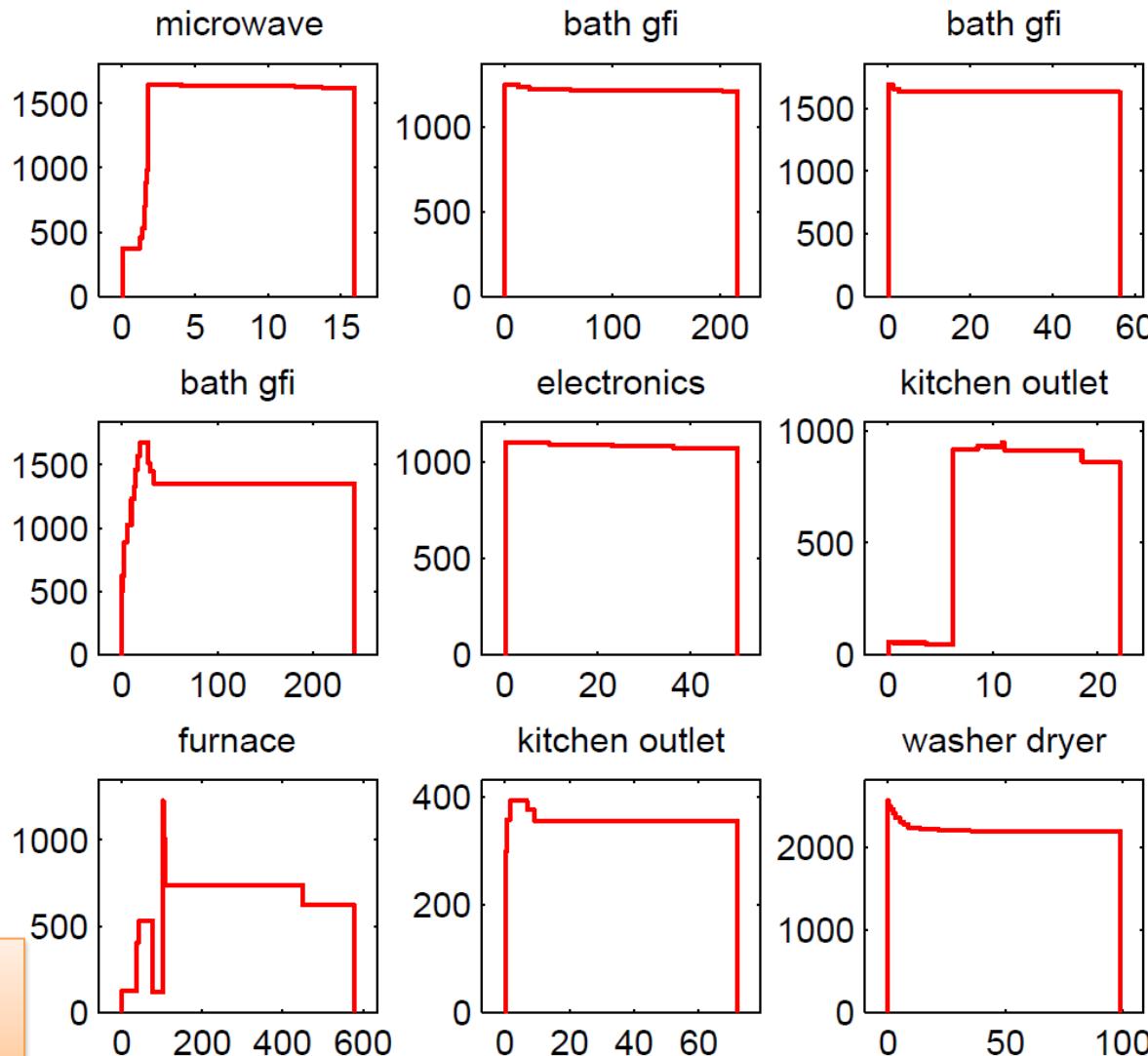
2. *Learning*  
(unsupervised)

Extract all potential device snippets from signal (power coming on and going off)



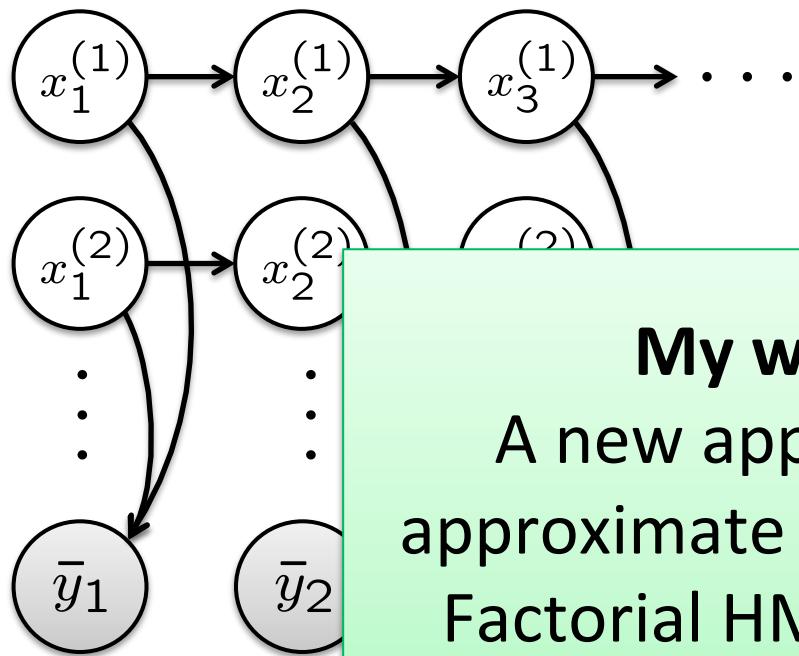
Compute similarities between snippets and use spectral clustering

# Learning with Spectral Clustering



2. **Learning**  
(unsupervised)

# Inference in Factorial HMMs



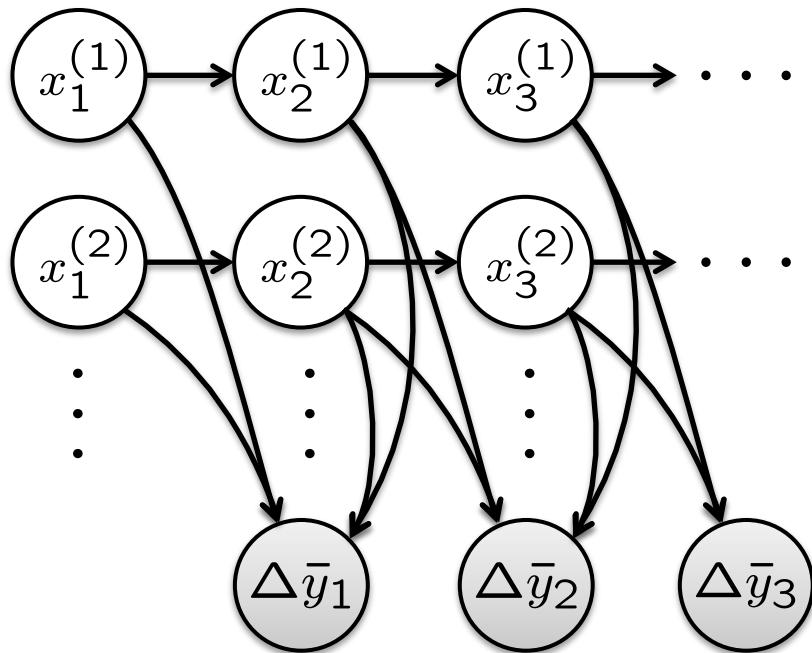
Given  $\bar{y}_{1:T}$ , find  $x_{1:T}^{(1:N)}$

**My work:**  
A new approach to  
approximate inference in  
Factorial HMMs based  
upon *convex optimization*

ence is intractable  
~10 states each →  
(total states)

# Addition #1: Signal Differences

- Rather than look only at absolute signal, look at ***differences*** between successive levels



$$\Delta\bar{y}_t | x_t^{(1:N)} \sim \mathcal{N} \left( \sum_{i=1}^N \mu_{x_{t+1}^{(i)}}^{(i)} - \mu_{x_t^{(i)}}^{(i)}, \Sigma \right)$$

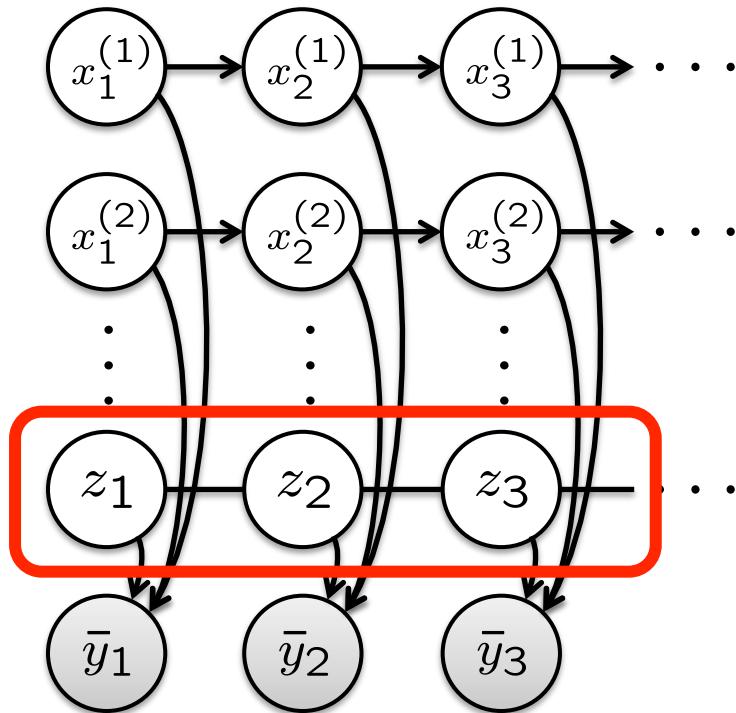
Would expect this be useful  
when devices change state  
one at a time

1. *Specify* model

3. *Inference*

# Addition #2: Robust HMM

- Not going to have a model for every device in the home, allow *unassigned* power



$$p(z_{1:T}) \propto \exp \left\{ -\lambda \sum_{t=1}^{T-1} |z_{t+1} - z_t| \right\}$$



**Total Variation** penalty, allows for arbitrary unknown power, but favors *piecewise-constant* signals

1. *Specify* model

3. *Inference*

# Inference as Optimization

- Most likely assignment (MAP inference) can now be cast as mixed-integer QP

Additive FHMM

$$\begin{aligned} & \text{maximize } \log p(x_{1:T}^{(1:N)}, z_{1:T} | \bar{y}_{1:T}) \\ & \text{subject to } Q(x_{1:T}^{(1:N)}) \in \mathcal{L}(G) \\ & \quad Q(x_{1:T}^{(1:N)}) \in \{0, 1\} \end{aligned}$$

Difference FHMM

$$\begin{aligned} & \text{maximize } \log p(x_{1:T}^{(1:N)}, \Delta z_{1:T} | \Delta \bar{y}_{1:T}) \\ & \text{subject to } Q(x_{1:T}^{(1:N)}) \in \mathcal{L}(G) \\ & \quad Q(x_{1:T}^{(1:N)}) \in \{0, 1\} \end{aligned}$$

**End result:** convex  
approximate inference  
method, can be solved  
quickly for hundreds of  
thousands of variables

QP

, Enforce one-at-a-time  
in posterior  
LP

, Drop integer constraint  
IP

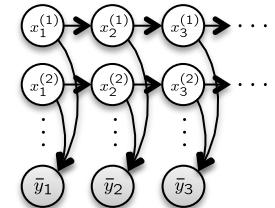
3. Inference

Solve Jointly

# Summary

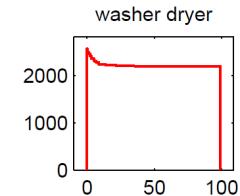
1. *Specify* model

Factorial HMM + 2 new additions:  
difference signal and robust component



2. *Learning*  
(unsupervised)

New learning approach based upon  
spectral clustering of device snippets

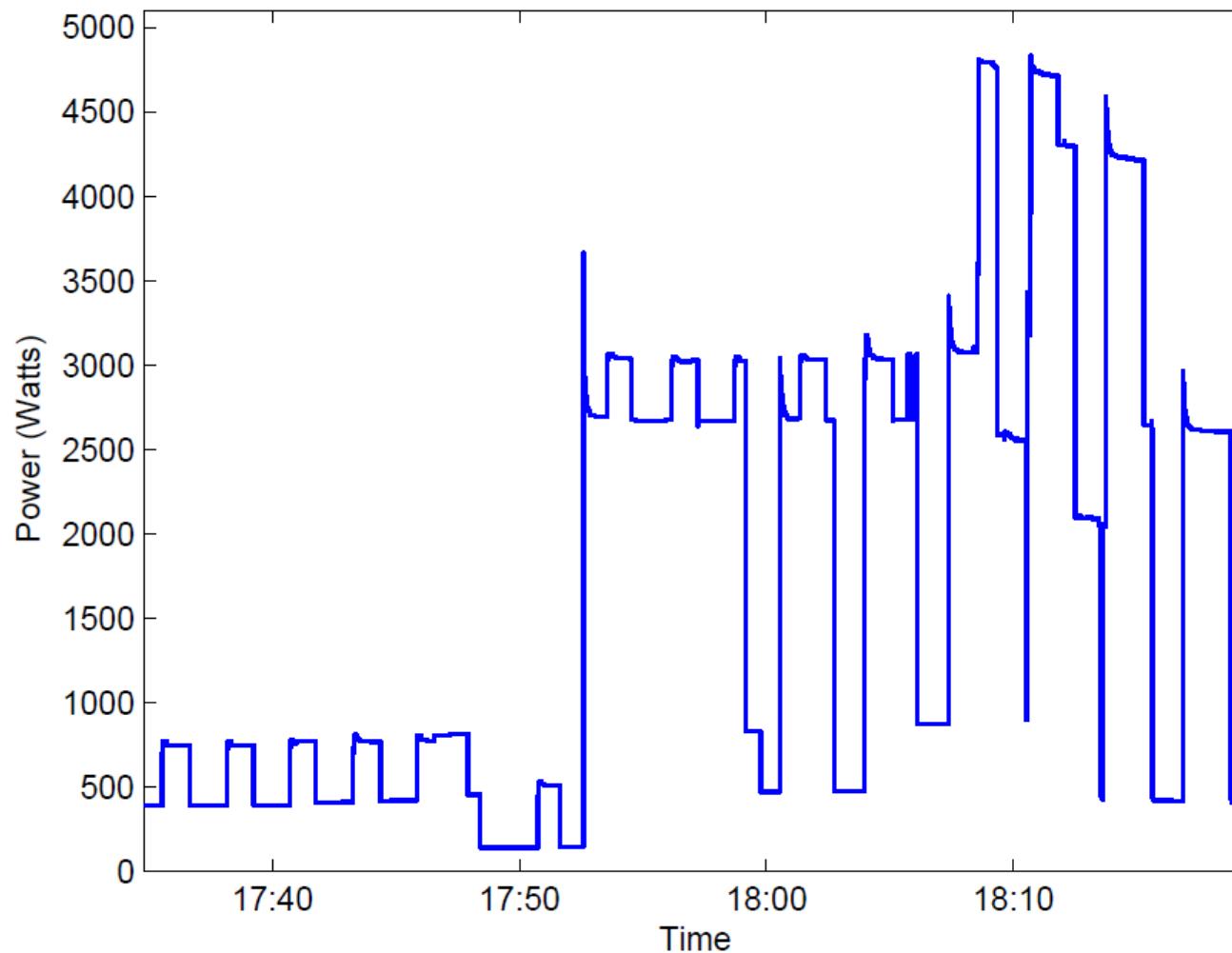


3. *Inference*

New inference procedure based on  
convex optimization, relaxations

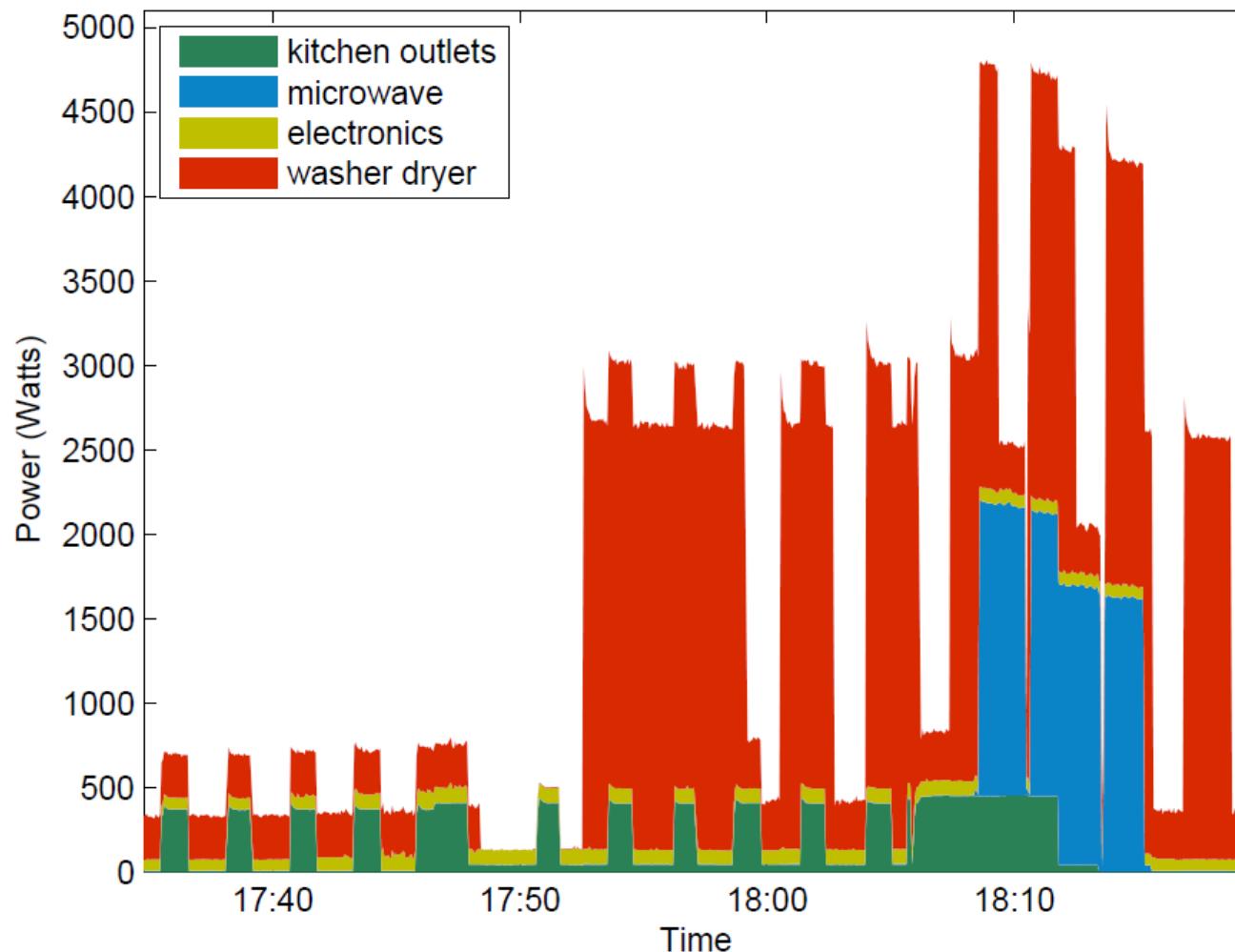
# Performance

Total Power



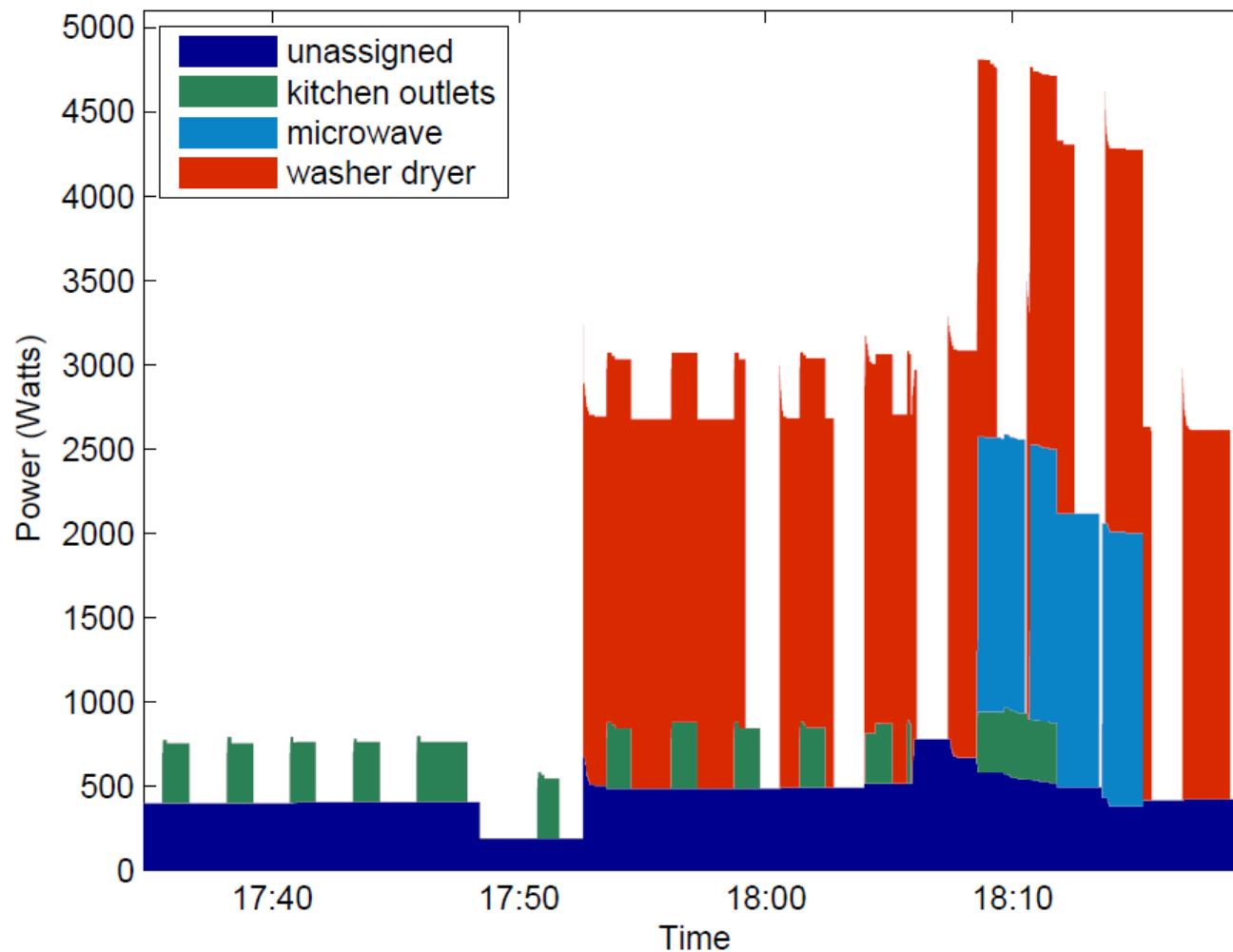
# Performance

True Breakdown



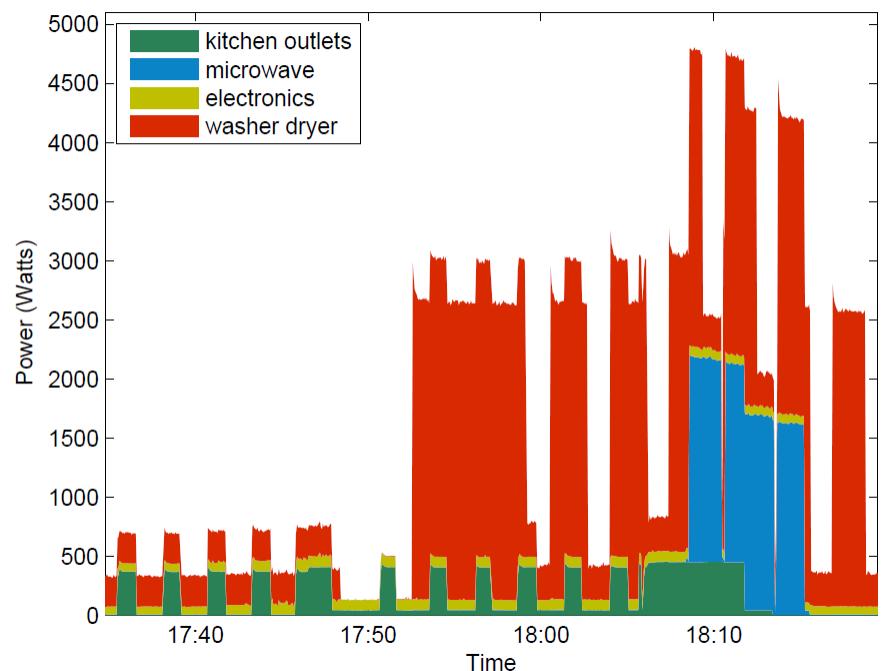
# Performance

Our Method

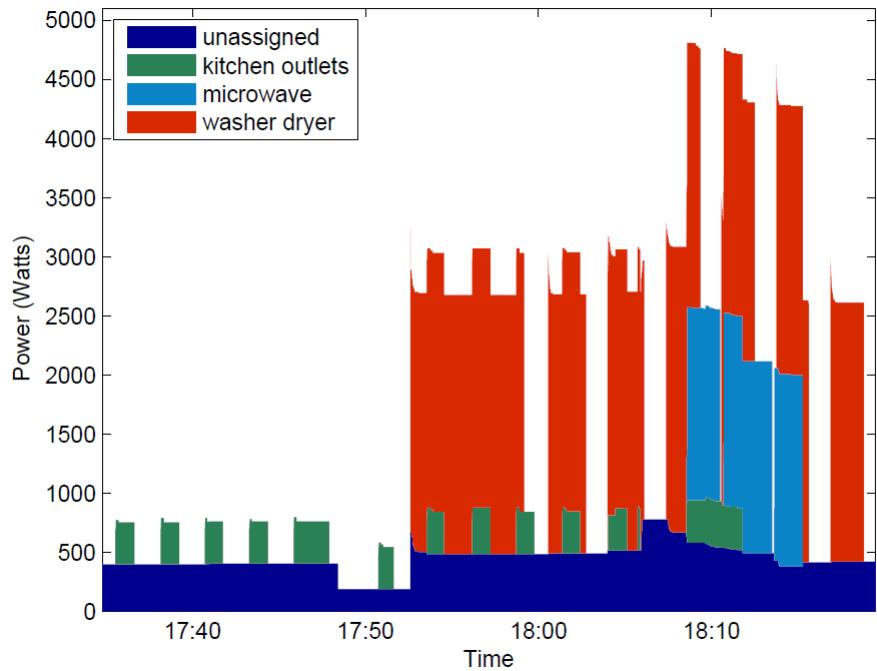


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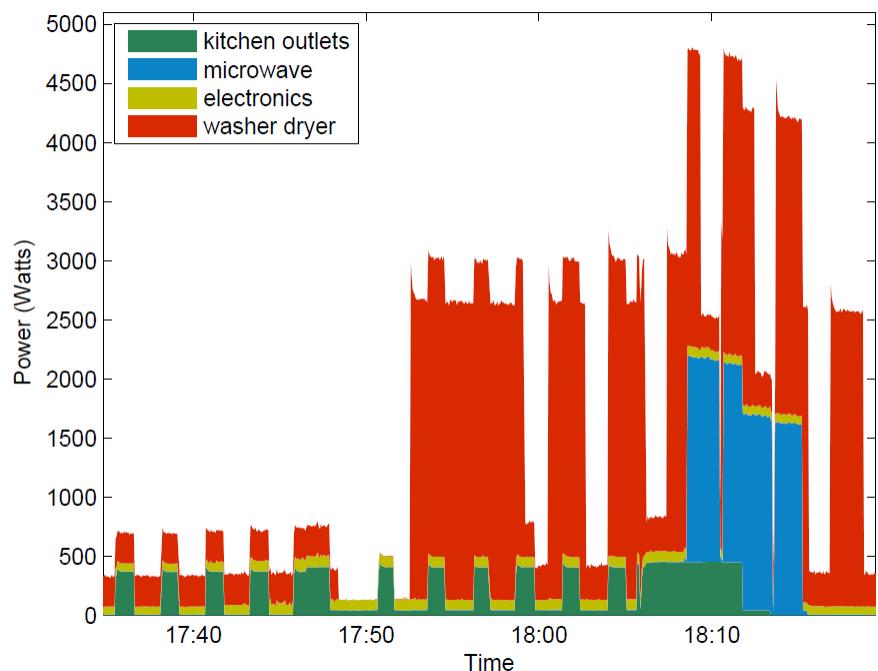


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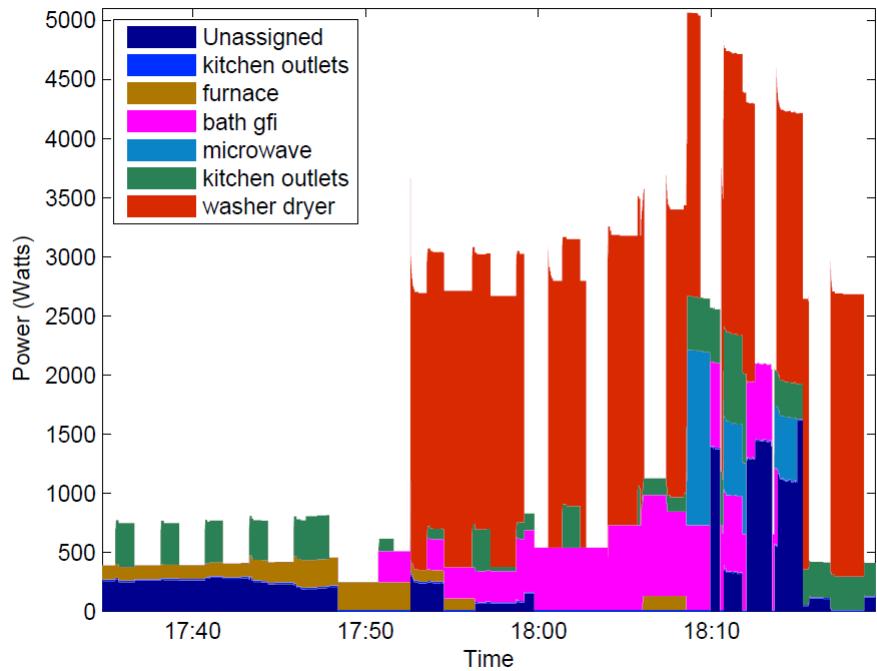


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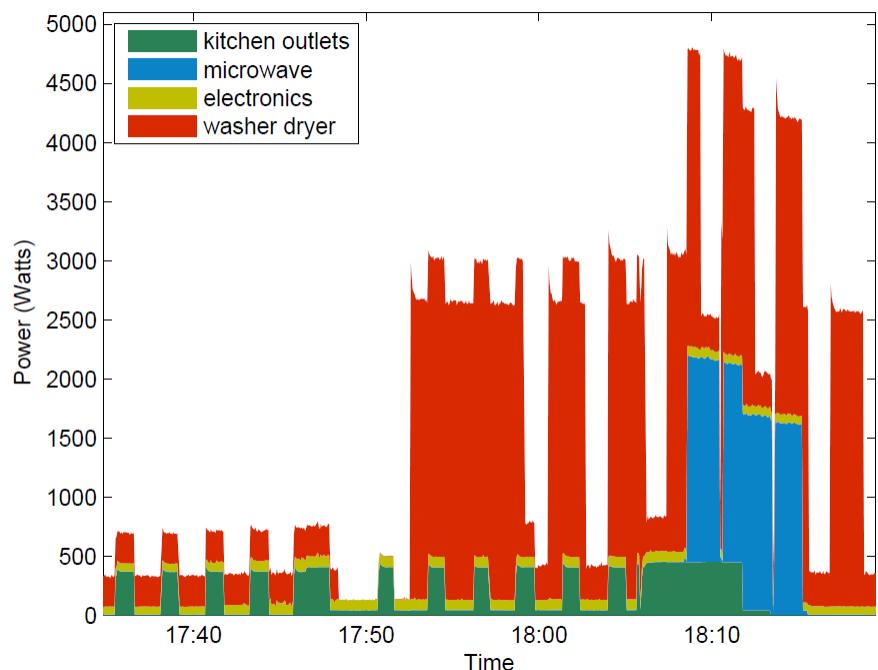


Event Based

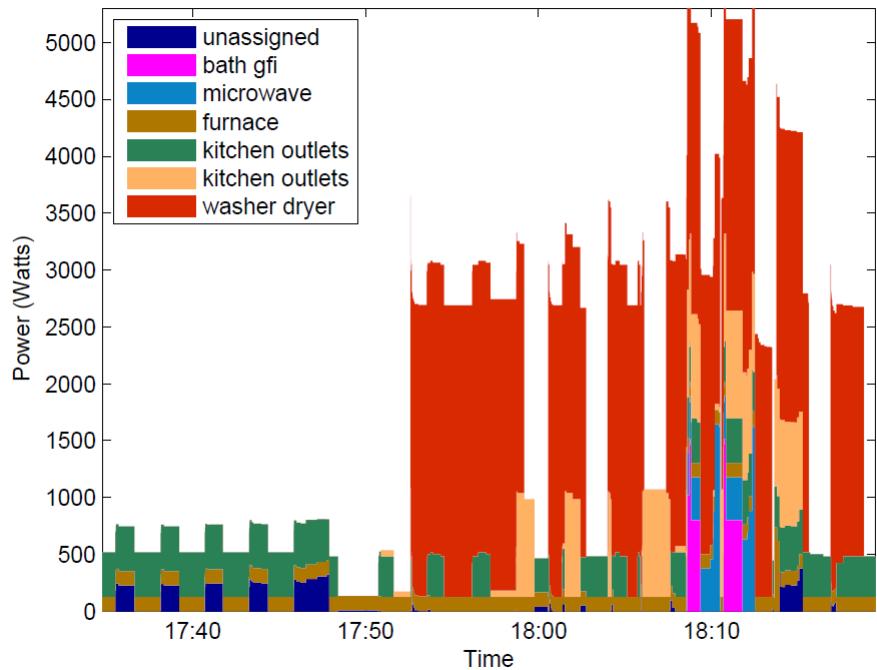


# Performance

True Breakdown



Structured Mean Field



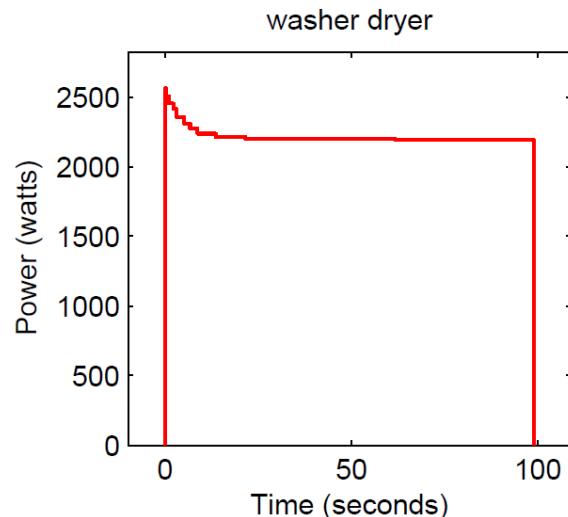
# Performance Over Two Weeks

Circuit	Our Method	Structured Mean Field	Event-based
Microwave	98% / 66%	97% / 4%	98% / 28%
Bath GFI	83% / 71%	50% / 9%	23% / 21%
Kitchen Outlets	38% / 13%	10% / 48%	57% / 15%
Furnace	92% / 71%	13% / 15%	25% / 71%
Kitchen Outlets	45% / 16%	13% / 24%	27% / 11%
Washer / Dryer	99% / 73%	89% / 77%	95% / 64%
<b>Total</b>	<b>87% / 60%</b>	<b>36% / 45%</b>	<b>49% / 53%</b>

**Performance measured by  
per-circuit precision/recall**

# Performance Over Two Weeks

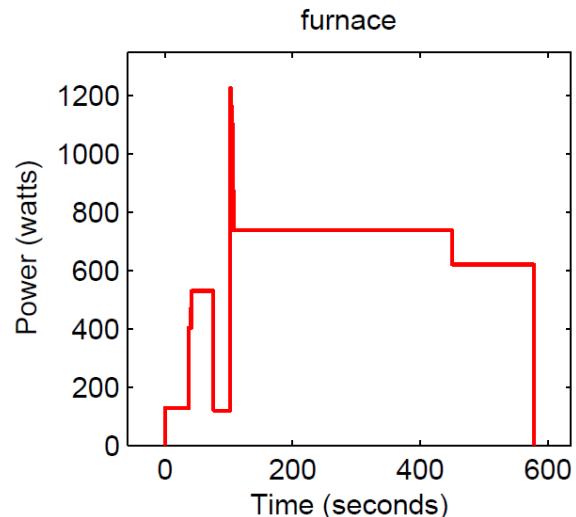
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# Directions for Future Work

- Iterated learning and inference, using initial models as priors
- Integrate with supervised learning procedures to automatically classify devices
- Integrate with state-of-the-art sensing and feature extraction
- Testing on additional homes (expanding REDD to 50 homes: <http://redd.csail.mit.edu>)